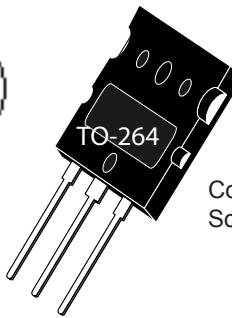
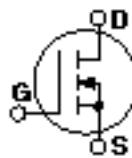




Microsemi[®]



**ARF468AG
ARF468BG**

Common
Source

RF POWER MOSFETs N-CHANNEL ENHANCEMENT MODE

150V 300W 45MHz

The ARF468A and ARF468B comprise a symmetric pair of common source RF power transistors designed for push-pull scientific, commercial, medical and industrial RF power amplifier applications up to 45 MHz. They have been optimized for both linear and high efficiency classes of operation.

- Specified 150 Volt, 40.68 MHz Characteristics:

Output Power = 300 Watts.

Gain = 15dB (Class AB)

Efficiency = 75% (Class C)

- Low Cost Common Source RF Package.

- Low V_{th} thermal coefficient.

- Low Thermal Resistance.

- Optimized SOA for Superior Ruggedness.

MAXIMUM RATINGS

All Ratings: T_C = 25°C unless otherwise specified.

Symbol	Parameter	Ratings	UNIT
V _{DSS}	Drain-Source Voltage	500	Volts
V _{DGO}	Drain-Gate Voltage	500	
I _D	Continuous Drain Current @ T _C = 25°C	22	Amps
V _{GS}	Gate-Source Voltage	±30	Volts
P _D	Total Power Dissipation @ T _C = 25°C	300	Watts
R _{θJC}	Junction to Case	0.35	°C/W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to 150	°C
T _L	Lead Temperature: 0.063" from Case for 10 Sec.	300	

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
BV _{DSS}	Drain-Source Breakdown Voltage (V _{GS} = 0V, I _D = 250 μA)	500			Volts
R _{DS(ON)}	Drain-Source On-State Resistance (V _{GS} = 10V, I _D = 11A)			0.3	ohms
I _{DSS}	Zero Gate Voltage Drain Current (V _{DS} = 500V, V _{GS} = 0V)			25	μA
	Zero Gate Voltage Drain Current (V _{DS} = 400V, V _{GS} = 0V, T _C = 125°C)			250	
I _{GSS}	Gate-Source Leakage Current (V _{GS} = ±30V, V _{DS} = 0V)			±100	nA
g _{fs}	Forward Transconductance (V _{DS} = 25V, I _D = 11A)	5	8	9	mhos
V _{GS(TH)}	Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 1mA)	2.5	4	5	Volts

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Microsemi Website - <http://www.microsemi.com>

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C_{iss}	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 150V$ $f = 1\text{ MHz}$		2230		
C_{oss}	Output Capacitance			230		pF
C_{rss}	Reverse Transfer Capacitance			105		

FUNCTIONAL CHARACTERISTICS

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
G_{PS}	Common Source Amplifier Power Gain	$f = 40.68\text{ MHz}$	14	15		dB
η	Drain Efficiency	$V_{GS} = 2.5V$ $V_{DD} = 150V$	70	75		%
Ψ	Electrical Ruggedness VSWR 10:1	$P_{out} = 300W$	No Degradation in Output Power			

① Pulse Test: Pulse width < 380μS, Duty Cycle < 2%

Microsemi Reserves the right to change, without notice, the specifications and information contained herein.

TYPICAL PERFORMANCE CURVES

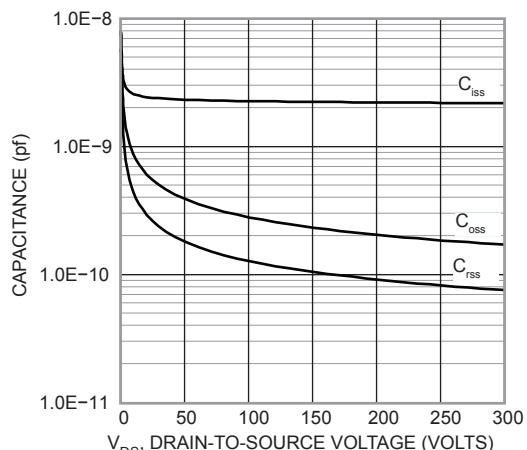


Figure 1, Typical Capacitance vs. Drain-to-Source Voltage

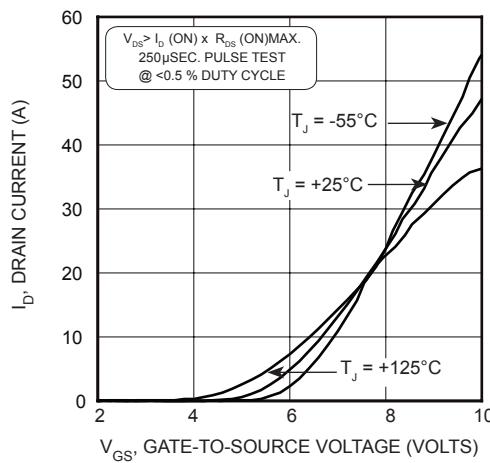


Figure 2, Typical Transfer Characteristics

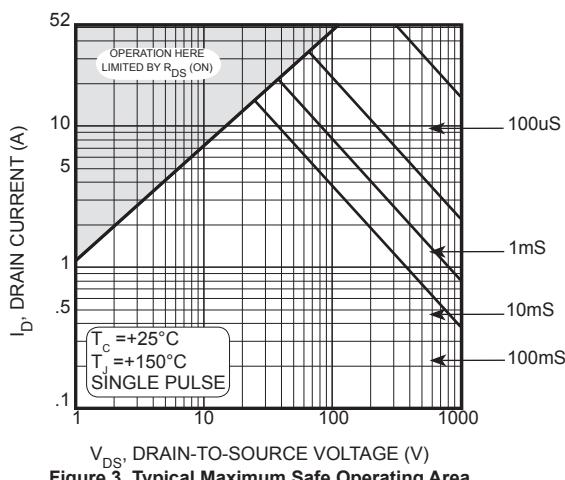


Figure 3, Typical Maximum Safe Operating Area

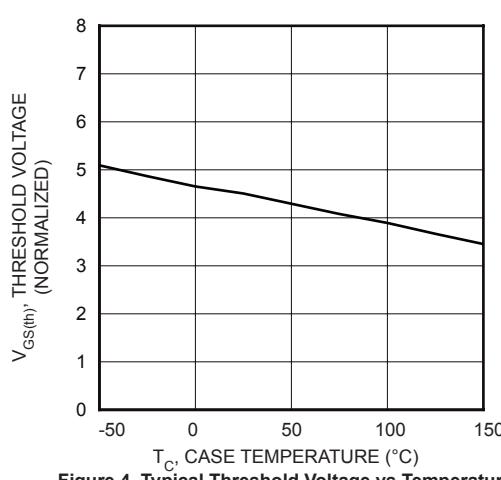


Figure 4, Typical Threshold Voltage vs Temperature

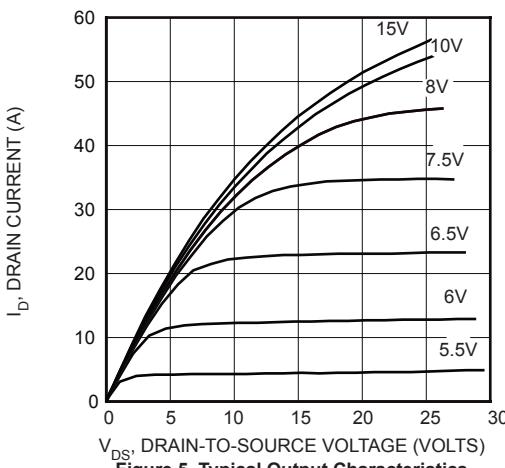


Figure 5, Typical Output Characteristics

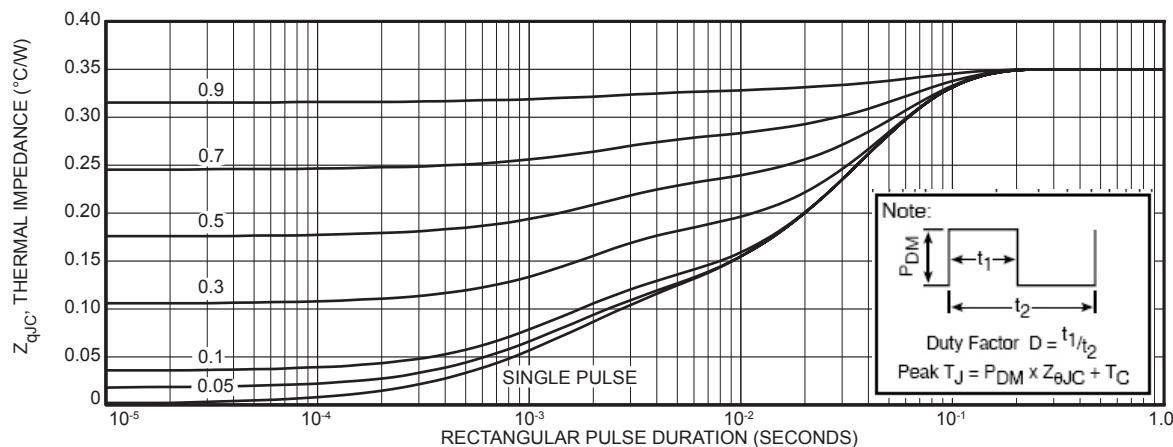


FIGURE 6a, MAXIMUM EFFECTIVE TRANSIENT THERMAL IMPEDANCE, JUNCTION-TO-CASE vs PULSE DURATION

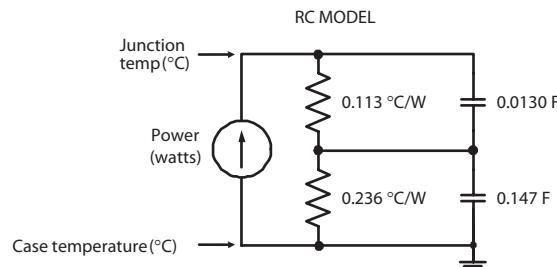
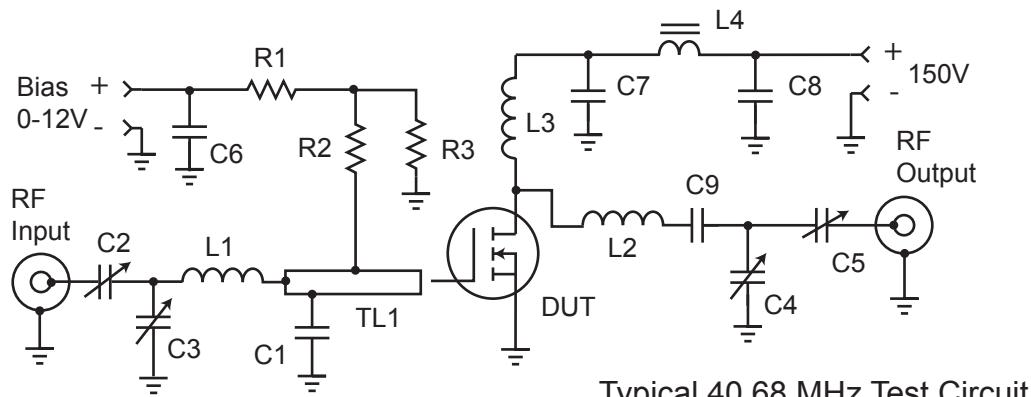


Figure 6b, TRANSIENT THERMAL IMPEDANCE

Table 1 - Typical Class AB Large Signal Input - Output Impedance

Freq. (MHz)	Z_{in} (Ω)	Z_{OL} (Ω)
2.0	$18 - j 10.5$	$21 - j 1.4$
13.5	$2.7 - j 4.6$	$17.5 - j 7.8$
27.1	$1.8 - j 1.6$	$11.7 - j 10.4$
40.7	$1.7 - j 0.2$	$7.7 - j 10$

 Z_{in} - Gate shunted with 25Ω $I_{dg} = 0$ Z_{OL} - Conjugate of optimum load for 300 Watts output at $V_{dd} = 125V$



C1 -- 2200pF ATC 700B

C2-C5 -- Arco 465 Mica trimmer

C6-C8 -- .1 μ F 500V ceramic chip

C9 -- 3x 2200 pF 500V chips COG

L1 -- 4t #22 AWG .25"ID .25 "L ~87nH

L2 -- 5t #16 AWG .312" ID .35" L ~176nH

L3 -- 10t #24 AWG .25"ID ~.5 μ HL4 -- VK200-4B ferrite choke 3 μ HR1- R3 -- 1k Ω 0.5 Ω CarbonTL1 -- 34 Ω t-line 0.175" x 1"

C1 .45" from gate pin.

PCB -- 0.062" FR4, Er=4.7

TO-264 (L) Package Outline